

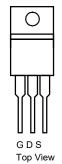
RoHS

COMPLIANT

F1704-VB Datasheet N-Channel 40-V (D-S) MOSFET

PRODUCT SUMMARY		
V _{DS}	40	V
R _{DS(on)} V _{GS} = 10 V	2	mΩ
ID	180	А
Configuration	Sin	gle



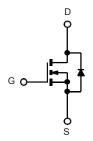


FEATURES

- Trench Power MOSFET
- 100 % R_g and UIS Tested

APPLICATIONS

- Synchronous Rectification
- Power Supplies



N-Channel MOSFET

Parameter		Symbol	Limit	Unit	
Drain-Source Voltage		V _{DS}	40		
Gate-Source Voltage		V _{GS}	± 20	V	
	T _C = 25 °C		180 ^{a, c}		
Continuous Drain Current (T _J = 175 °C)	T _C = 70 °C		150°		
	T _A = 25 °C	I _D	29 ^b	A	
	T _A = 70 °C		23 ^b		
Pulsed Drain Current		I _{DM}	350		
Avalanche Current Pulse	L = 0.1 mH	I _{AS}	80		
Single Pulse Avalanche Energy	L = 0.1 IIIH	E _{AS}	320	mJ	
Continuous Source-Drain Diode Current	T _C = 25 °C	I _S	110 ^{a, c}	A	
Continuous Source-Drain Diode Current	T _A = 25 °C	's	2.6 ^b	A	
	T _C = 25 °C		312ª		
Maximum Dawar Dissinction	T _C = 70 °C	P _D	200	w	
Maximum Power Dissipation	T _A = 25 °C	'D	3.13 ^b	VV	
	T _A = 70 °C		2.0 ^b		
Operating Junction and Storage Temperature R	ange	T _J , T _{stg}	- 55 to 150	°C	

THERMAL RESISTANCE RATINGS					
Parameter		Symbol	Typical	Maximum	Unit
Maximum Junction-to-Ambient ^b	Steady State	R _{thJA}	32	40	°C/W
Maximum Junction-to-Case	Steady State	R _{thJC}	0.33	0.4	0/11

Notes:

a. Based on $T_C = 25$ °C.

b. Surface Mounted on 1" x 1" FR4 board.

c. Calculated based on maximum junction temperature. Package limitation current is 110 A.

SPECIFICATIONS T _J = 25 °C, unl Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Unit
Static	Symbol	Test conditions	wiin.	тур.	wax.	Unit
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} = 0 V, I _D = 250 μA	40		1	V
V _{DS} Temperature Coefficient	△ V _{DS} /T _J	VGS 0 V, 10 200 µ. (40	41		V
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I _D = 250 μA		- 8		mV/°(
Gate-Source Threshold Voltage		V _{DS} = V _{GS} , I _D = 250 µA	2.0	- 0	1.0	V
	V _{GS(th)}	$V_{DS} = 0 V, V_{GS} = \pm 20 V$	2.0		4.0 ± 100	nA
Gate-Source Leakage	I _{GSS}	$V_{DS} = 40 \text{ V}, \text{ V}_{GS} = 120 \text{ V}$				na I
Zero Gate Voltage Drain Current	I _{DSS}	$V_{DS} = 40 \text{ V}, V_{GS} = 0 \text{ V}$ $V_{DS} = 40 \text{ V}, V_{GS} = 0 \text{ V}, T_J = 55 \text{ °C}$			1 10	μA
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, \text{ V}_{GS} = 10 \text{ V}$	120		10	A
	D(ON)	$V_{GS} = 10 \text{ V}, \text{ I}_{D} = 30 \text{ A}$	120	2		
Drain-Source On-State Resistance ^a	R _{DS(on)}	$V_{GS} = 4.5 \text{ V}, \text{ I}_{D} = 20 \text{ A}$	15			— mΩ
Forward Transconductance ^a	9 _{fs}	$V_{DS} = 15 \text{ V}, \text{ I}_{D} = 30 \text{ A}$		180		S
Dynamic ^b	010					
Input Capacitance	C _{iss}			9000		
Output Capacitance	C _{oss}	V _{DS} = 20 V, V _{GS} = 0 V, f = 1 MHz		650		pF
Reverse Transfer Capacitance	C _{rss}			450		1
Total Gate Charge	Qq			120		
Gate-Source Charge	Q _{gs}	V _{DS} = 20 V, V _{GS} = 10 V, I _D = 20 A		30		nC
Gate-Drain Charge	Q _{gd}			16		1
Gate Resistance	R _g	f = 1 MHz		0.85	1.3	Ω
Turn-On Delay Time	t _{d(on)}			20	30	
Rise Time	t _r	V _{DD} = 20 V, R _L = 1.0 Ω		11	17	-
Turn-Off Delay Time	t _{d(off)}	$I_D{\cong}20$ A, V_{GEN} = 10 V, R_g = 1 Ω		77	115	
Fall Time	t _f			10	15	1
Turn-On Delay Time	t _{d(on)}			102	155	ns
Rise Time	t _r	V _{DD} = 20 V, R _L = 1.0 Ω		62	95	-
Turn-Off Delay Time	t _{d(off)}	$I_D{\cong}20$ A, V_{GEN} = 4.5 V, R_g = 1 Ω		180	270	
Fall Time	t _f			60	90	
Drain-Source Body Diode Characteristic	s		1	1	1	
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			110	A
Pulse Diode Forward Current ^a	I _{SM}				200	
Body Diode Voltage	V _{SD}	I _S = 20 A		0.8	1.2	V
Body Diode Reverse Recovery Time	t _{rr}			50	75	ns
Body Diode Reverse Recovery Charge	Q _{rr}	I _F = 20 A, di/dt = 100 A/μs, T _J = 25 °C		70	105	nC
Reverse Recovery Fall Time	t _a	$r_{\rm F} = 20$ A, $a_{\rm F}a_{\rm C} = 100$ A/ μ s, $1j = 20$ C		30		
Reverse Recovery Rise Time	t _b			20		ns

a. Pulse test; pulse width \leq 300 $\mu s,$ duty cycle \leq 2 %.

b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

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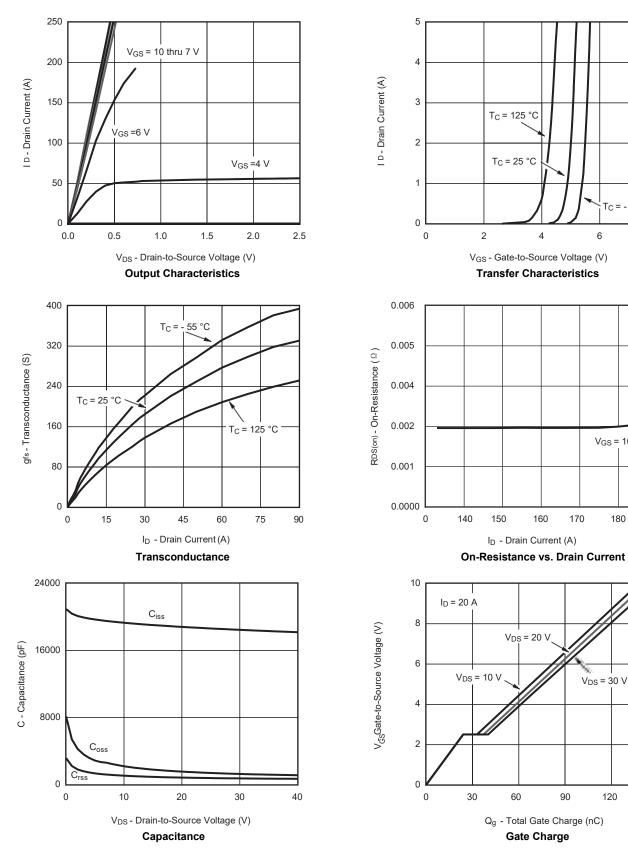
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T_C = - 55 °C

V_{GS} = 10 V

V_{DS} = 30 V

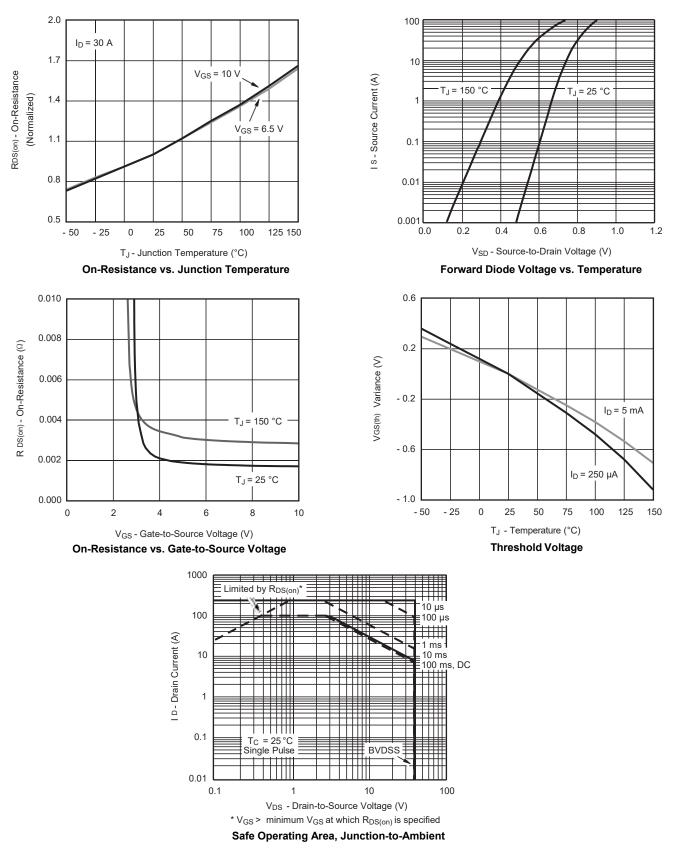
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



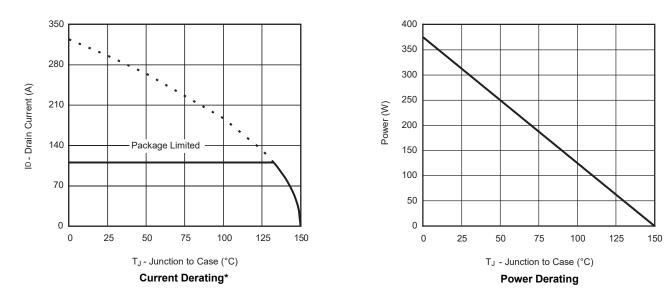
服务热线:400-655-8788



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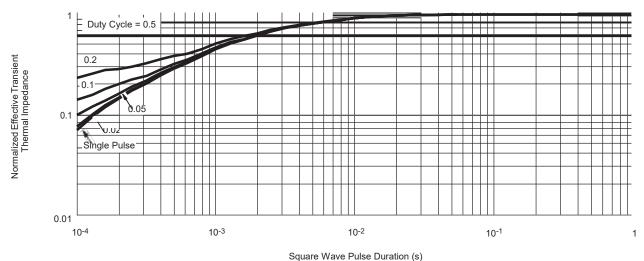






TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

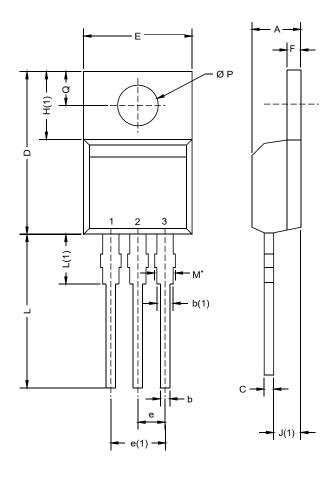
* The power dissipation P_D is based on $T_{J(max)}$ = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



Normalized Thermal Transient Impedance, Junction-to-Case



TO-220AB



	MILLIM	IETERS	INCHES		
DIM.	MIN.	MAX.	MIN.	MAX.	
А	4.25	4.65	0.167	0.183	
b	0.69	1.01	0.027	0.040	
b(1)	1.20	1.73	0.047	0.068	
с	0.36	0.61	0.014	0.024	
D	14.85	15.49	0.585	0.610	
E	10.04	10.51	0.395	0.414	
е	2.41	2.67	0.095	0.105	
e(1)	4.88	5.28	0.192	0.208	
F	1.14	1.40	0.045	0.055	
H(1)	6.09	6.48	0.240	0.255	
J(1)	2.41	2.92	0.095	0.115	
L	13.35	14.02	0.526	0.552	
L(1)	3.32	3.82	0.131	0.150	
ØР	3.54	3.94	0.139	0.155	
Q	2.60	3.00	0.102	0.118	
ECN: X12- DWG: 547	-0208-Rev. N, 1	08-Oct-12			

Notes

* M = 1.32 mm to 1.62 mm (dimension including protrusion) Heatsink hole for HVM



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